

Amtron Technology, Inc.

Industrial Grade CompactFlash Card

AC Series

Product Datasheet

V2.0

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1. INTRODUCTION



1.1. Description

Amtron industrial grade AC series CompactFlash (CF) memory cards are CompactFlash™ Card Specification 6.x compliant. These CF cards are designed with the highest endurance single-level cell (SLC) flash and multi-level cell (MLC) NAND flash and are offered in wide operating temperature grade (-40°C - +85°C) and optional standard operating temperature grade (0°C – 70°C). The memory capacities are available from 256MB up to 128GB.

1.2. Product Features

- RoHS compliant [Lead free]
- CompactFlash™ Card Specification 3.x, 4.x, 5.x, 6.x compliant
- Compatible with PCMCIA/IDE interface
- Operating Modes:
 - PC Card Standard Release 8.0
 - True IDE Mode
 - PIO up to mode 6
 - Multiword DMA (MDMA) up to mode 4
 - Ultra DMA (UDMA) up to mode 7
- Reliable wear-leveling algorithm to ensure the best of flash endurance.
- High speed:
 - Read: 137 MB/s max
 - Write: 95 MB/s max
- Endure severe thermal and dynamic environments
- MTBF *
 - SLC: > 3,000,000 hours
 - pSLC, MLC: > 2,000,000 hours
- Write Protection (optional, Section 2.6)
- Quick Erase (optional, Section 2.7)
- Power Loss Protection (optional, Section 2.8)
- Controlled Bill of Materials (BOM)

***Note:** A lower MTBF is expected for higher capacity drives. To be conservative, the lowest MTBF is reported in this document

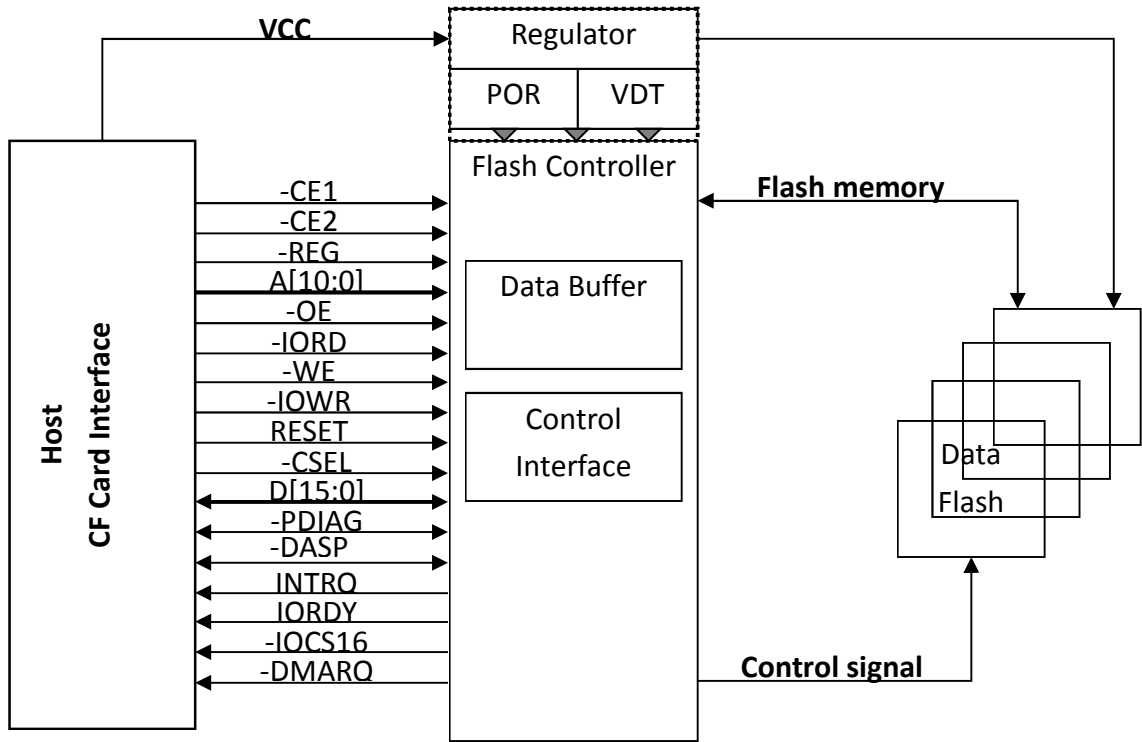
1.3. Product Overview

- **Host Interface**
 - PCMCIA/IDE
 - CompactFlash 3.x, 4.x, 5.x, 6.x
- **Form Factor**
 - CompactFlash Type I
- **Flash Type**
 - SLC, MLC and pSLC
- **Capacity**
 - SLC: 256MB up to 64GB
 - pSLC: 4GB up to 128GB
 - MLC: 8GB up to 256GB
- **Performance**
 - Read: up to 137 MB/s
 - Write: up to 95 MB/s
- **MTBF¹**
 - SLC > 3,000,000 hours
 - pSLC and MLC > 2,000,000 hours
- **Advanced Flash Management**
 - Static and Dynamic Wear Leveling
 - Bad Block Management
- **Temperature Range**
 - Operation (standard): 0°C to 70°C
 - Operation (wide): -40°C to 85°C
 - Storage: -40°C to 85°C
- **Low Power Management**
 - Power Sleep Mode
- **Power Consumption²**
 - Read mode: < 220mW
 - Write mode: < 220mA
 - Idle mode: < 6.5 mA
- **Compliant**
 - RoHS
 - CE & FCC
- **Optional Features³**
 - Write Protection (see Section 2.6)
 - Quick Erase (see Section 2.7)
 - Power Loss Protection (see Section 2.8)

Note:

1. **MTBF** (mean time between failures) is a measure of how reliable a hardware product is. Its value represents the average time between a failure repair and the next failure. The unit of MTBF is typically in hours. The higher the MTBF value, the higher the reliability of the product. Please note that a lower MTBF is expected for higher capacity drives. To be conservative, the lowest MTBF is reported in this document.
2. See Section 4.2 “Power Consumption” for details.
3. Optional features: See Section 8 “Part Number Decoder”.

1.4. Block Diagram



CompactFlash (CF) Card Block Diagram

2. PRODUCT SPECIFICATIONS



2.1. Product Dimension

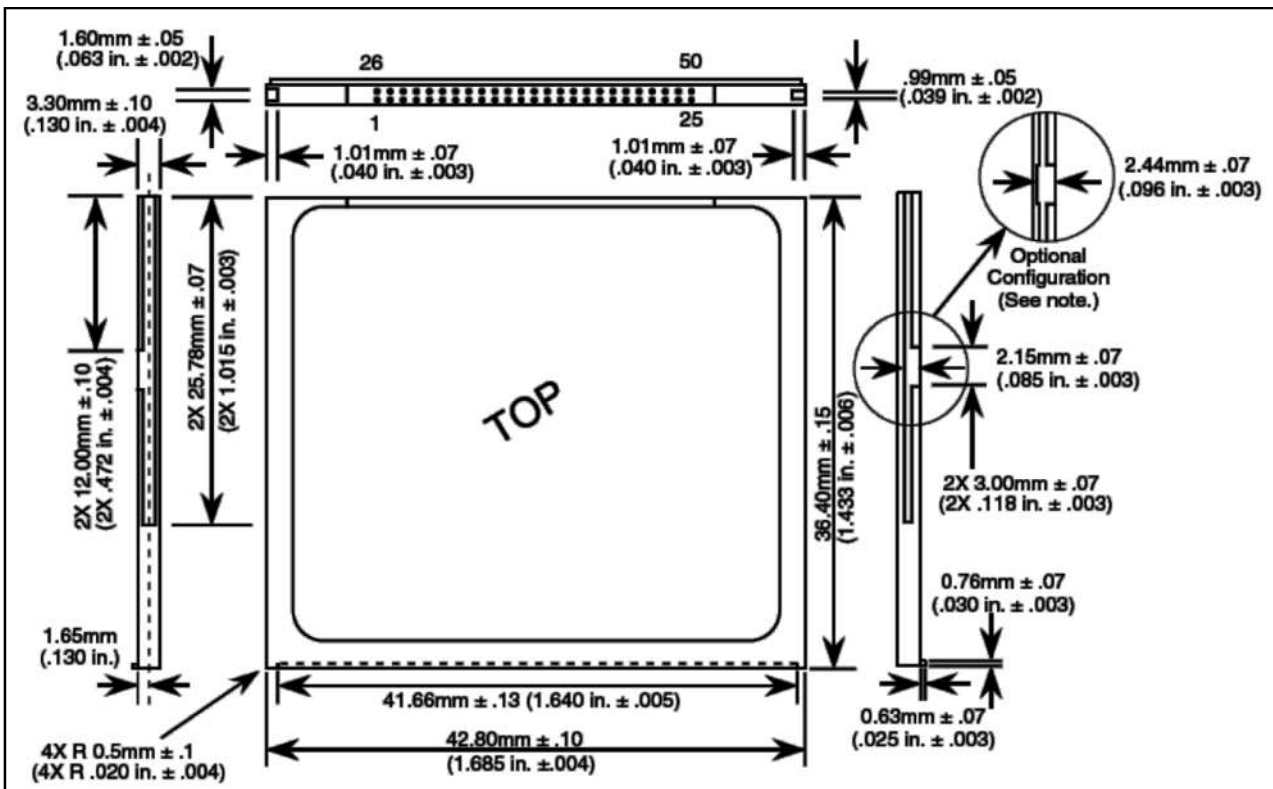
36.40mm (L) x 42.80mm (W) x 3.30mm (H)

Length: 36.40 ± 0.15 mm

Width: 42.80 ± 0.10 mm

Thickness: 3.3 mm ± 0.10 mm

Weight: 12 g typical, 14 g maximum



2.2. Specifications

- **Capacity**
 - SLC: 256MB up to 64GB
 - pSLC: 4GB up to 128GB
 - MLC: 8GB up to 256GB
- **Supported Host Interfaces:**
 - PCMCIA/IDE Interface (support up to PIO Mode 6/Multi Word DMA Mode 4/PCMCIA Ultra DMA Mode 7/Ultra DMA Mode 7)
 - Fully compatible with CompactFlash Specification Version 3.x, 4.x, 5.x and 6.x
 - Fully compatible with PC Card Standard Release 8.0
 - Fully compatible with the IDE standard interface
 - Host Transfer Rate for PC Card/CompactFlash: 25MB/s (PIO6)
 - Host Transfer Rate for IDE standard interface: 166MB/s (UDMA7)
- **NAND Flash Interface**
 - Support SLC/ MLC / pSLC NAND flash memory
 - Support 16KB data per page NAND flash memory
- **ECC Scheme**
 - Up to 72 bits / 1K Byte
- **Operating Voltage: 3.0 ~ 5.5V**
- **Power-saving implementation**
- **Support Static/Dynamic Wear Leveling function**
- **Support CFA VPG-20 Specification**
- **Light weight and noiseless**
- **Auto-detection of CF/ATA host interface**
- **Support Write Protection function by slide switch (Optional)**
- **Support Quick Erase function by slide switch (Optional)**
- **Support Power Loss Protection Lite (Optional)**

- Performance

- SLC

Capacity	Flash Structure	Flash Type	Sequential	
			Read (MB/s)	Write (MB/s)
256MB	256MBx1	24nm TSOP	24.749 MB/s	10.696 MB/s
512MB	512MBx1	32nm TSOP	32.503 MB/s	23.489 MB/s
1GB	1GBx1	32nm TSOP	31.666 MB/s	20.763 MB/s
2GB	1GBx2	32nm TSOP	62.713 MB/s	39.849 MB/s
4GB	4GBx1	24nm TSOP	39.001 MB/s	34.187 MB/s
	2GBx2	32nm TSOP	69.624 MB/s	53.896 MB/s
	1GB x4	24nm TSOP	67.453 MB/s	48.912 MB/s
8GB	4GBx2	24nm TSOP	76.964 MB/s	68.164 MB/s
8GB	8GBx1	24nm TSOP	39.220 MB/s	35.022 MB/s
16GB	4GBx4	24nm TSOP	83.244 MB/s	72.568 MB/s
32GB	8GBx4	24nm TSOP	83.233 MB/s	70.322 MB/s
64GB	16GBx4	24nm TSOP	81.130 MB/s	71.030 MB/s

- MLC

Capacity	Flash Structure	Flash Type	Sequential	
			Read (MB/s)	Write (MB/s)
8GB	8GBx1	15nm TSOP	79.275 MB/s	28.103 MB/s
16GB	16GBx1	15nm TSOP	78.864 MB/s	25.586 MB/s
16GB	8GBx2	15nm TSOP	117.440 MB/s	54.114 MB/s
32GB	16GBx2	15nm TSOP	123.931 MB/s	49.501 MB/s
64GB	16GBx4	15nm TSOP	137.363 MB/s	95.636 MB/s
64GB	32GBx2	15nm TSOP	125.205 MB/s	95.643 MB/s
128GB	32GBx4	15nm TSOP	129.199 MB/s	128.346 MB/s
128GB	64GBx2	15nm TSOP	137.183 MB/s	123.033 MB/s
256GB	64GBx4	15nm TSOP	141.975 MB/s	135.062 MB/s

- pSLC

Capacity	Flash Structure	Flash Type	Sequential	
			Read (MB/s)	Write (MB/s)
4GB	8GBx1	15nm TSOP	79.275 MB/s	28.103 MB/s
8GB	16GBx1	15nm TSOP	78.864 MB/s	25.586 MB/s
8GB	8GBx2	15nm TSOP	117.440 MB/s	54.114 MB/s
16GB	16GBx2	15nm TSOP	123.931 MB/s	49.501 MB/s
32GB	16GBx4	15nm TSOP	137.363 MB/s	95.636 MB/s
32GB	32GBx2	15nm TSOP	125.205 MB/s	95.643 MB/s
64GB	32GBx4	15nm TSOP	129.199 MB/s	128.346 MB/s
64GB	64GBx2	15nm TSOP	137.183 MB/s	123.033 MB/s
128GB	64GBx4	15nm TSOP	141.975 MB/s	135.062 MB/s

2.3. Compliance

- Up to ATA/ATAPI-8 (Including S.M.A.R.T)

2.4. Reliability

Data Reliability	< 1 non-recoverable error in 10^{14} bits read < 1 erroneous correction in 10^{20} bits read
Data Retention	- 10% of program / Erase Endurance cycles: 10 Years - 100% of program / Erase Endurance cycles: 1 Years

2.5. MTBF

MTBF (mean time between failures) is a measure of how reliable a hardware product is. Its value represents the average time between a failure repair and the next failure. The unit of MTBF is typically in hours. The higher the MTBF value, the higher the reliability of the product. Please note that a lower MTBF is expected for higher capacity drives. To be conservative, the lowest MTBF is reported in this document.

SLC > 3,000,000 hours

pSLC, MLC > 2,000,000 hours

2.6. Write Protection (optional)

- **Write Protection (Read only)**

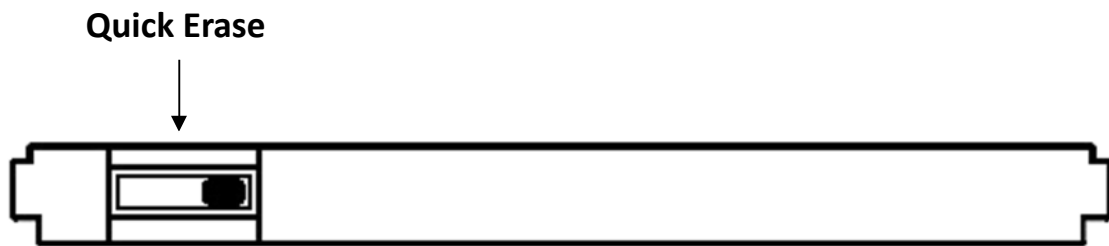
The write protection function is triggered by the switch as shown below. This is used to set the device as a write protection device after power up. When the function is triggered, data cannot be written to the device. The device is then set as read only.



2.7. Quick Erase (optional)

- **Erase user data only**

The Quick Erase function is a special feature to allow users to erase user data of CompactFlash Card by hardware trigger. When this feature is triggered by the switch as shown below, the storage blocks of CompactFlash Card will be erased and the CompactFlash Card will return to its factory default setting. This feature is particularly useful for urgent circumstances to quickly erase user data.



3. ENVIRONMENTAL SPECIFICATIONS



3.1. Environmental Conditions

3.1.1. Temperature and Humidity

- Temperature:
 - ◆ Storage: -40°C to 85°C
 - ◆ Operational (Standard grade): 0°C to 70°C
 - ◆ Operational (Wide grade): -40°C to 85°C
- Humidity:
 - ◆ Standard grade: RH 90% under 40°C (operational)
 - ◆ Wide grade: RH 95% under 55°C (operational)

■ High Temperature Test Condition

	Temperature	Humidity	Test Time
Operation (Standard)	70°C	0% RH	72 hours
Operation (Wide)	85°C	0% RH	72 hours
Storage (Standard)	85°C	0% RH	72 hours
Storage (Wide)	85°C	0% RH	168 hours

Result: No any abnormality is detected.

■ Low Temperature Test Condition

	Temperature	Humidity	Test Time
Operation (Standard)	0°C	0% RH	72 hours
Operation (Wide)	-40°C	0% RH	72 hours
Storage (Standard)	-40°C	0% RH	72 hours
Storage (Wide)	-40°C	0% RH	168 hours

Result: No any abnormality is detected.

■ High Humidity Test Condition

	Temperature	Humidity	Test Time
Operation (Standard)	40°C	93% RH	24 hours
Operation (Wide)	55°C	95% RH	72 hours
Storage (Standard)	40°C	95% RH	72 hours
Storage (Wide)	55°C	95% RH	96 hours

Result: No any abnormality is detected.

■ Temperature Cycle Test

	Temperature	Test Time	Cycle
Operation (Standard)	0°C	30 min	10 cycles
	70°C	30 min	
Operation (Wide)	-40°C	30 min	20 cycles
	85°C	30 min	
Storage (Standard)	-40°C	30 min	10 cycles
	85°C	30 min	
Storage (Wide)	-40°C	30 min	50 cycles
	85°C	30 min	

Result: No any abnormality is detected.

3.1.2. Shock

■ Shock Specification

	Acceleration Force	Half Sin Pulse Duration
Operational	1500G	0.5ms

Result: No any abnormality is detected when power on.

3.1.3. Altitude

Operating	Non-operating
50,000 feet maximum	

3.1.4. Vibration

■ Vibration Specification

	Condition		Vibration Orientation
	Frequency/Displacement	Frequency/Acceleration	
Operational	20Hz~80Hz/1.52mm	80Hz~2000Hz/20G	X, Y, Z axis/60 min for each

Result: No any abnormality is detected when power on.

3.1.5. Drop

■ Drop Specification

	Height of Drop	Number of Drop
Non-operational	80cm free fall	6 face of each unit

Result: No any abnormality is detected when power on.

3.1.6. Bending

■ **Bending Specification**

	Force	Action
Non-operational	≥50N	Hold 1min/5times

Result: No any abnormality is detected when power on.

3.1.7. Torque

■ **Torque Specification**

	Force	Action
Non-operational	0.5N-m or 5 deg	Hold 1min/5times

Result: No any abnormality is detected when power on.

3.1.8. Electrostatic Discharge (ESD)

■ **Contact ESD Specification**

Device	Capacity	Temperature	Relative Humidity	+/- 4KV	Result
CompactFlash™	64GB	24.0°C	49% (RH)	Device functions are affected, but EUT will be back to its normal or operational state automatically.	PASS

3.2. Certification & Compliance

- RoHS
- CE/FCC

4. ELECTRICAL SPECIFICATIONS



4.1. Supply Voltage

Parameter	Rating
Operating Voltage	3.3V and 5V

4.2. Power Consumption

Read	Write	Idle
220	220	6.5

Unit: mA

NOTES:

1. Samples were built using Toshiba NAND flash.
2. The operating voltage is 3.3V.
3. Sequential R/W is measured while testing 4000MB sequential R/W 5 times by CrystalDiskMark.
4. Power Consumption may vary from flash configuration or platform.

4.3. Absolute Maximum Rating

Item	Symbol	Parameter	MIN	MAX	Unit	Remark
1	$V_{DD}-V_{SS}$	DC Power Supply	-0.3	+5.5	V	
2	V_{IN}	Input Voltage	$V_{SS}-0.3$	$V_{DD}+0.3$	V	
3	T_a	Operating Temperature	0	+70	°C	Commercial Grade
4	T_{st}	Storage Temperature	-25	+85	°C	Commercial Grade
5	T_a	Operating Temperature	-40	+85	°C	Industrial Grade
6	T_{st}	Storage Temperature	-40	+85	°C	Industrial Grade

Parameter	Symbol	Min	TYP	MAX	Unit
V_{DD} Voltage	V_{DD}	3.0	3.3	3.6	V
		4.5	5.0	5.5	V

4.4. DC Characteristics

Table 4-1 DC Characteristics of 5.0V I/O Cells (Host Interface)

Symbol	Parameter	Conditions	MIN	TYP	MAX	Unit
V _{ol}	Output Low voltage	I _{ol} = 4 ~ 32 mA	-	-	0.4	V
V _{oh}	Output High voltage	I _{oh} = 4 ~ 32 mA	2.4	-	-	V
R _{pu}	Input Pull-Up Resistance	PU=high, PD=low	200	300	450	KΩ
R _{pd}	Input Pull-Down Resistance	PU=high, PD=low	200	300	450	KΩ
I _{in}	Input Leakage Current	V _{in} = VCC3I or 0	-10	±1	10	μA
I _{oz}	Tri-state Output Leakage Current		-10	±1	10	μA

4.5. AC Characteristics

4.5.1. PCMCIA Interface

Attribute Memory Read Timing

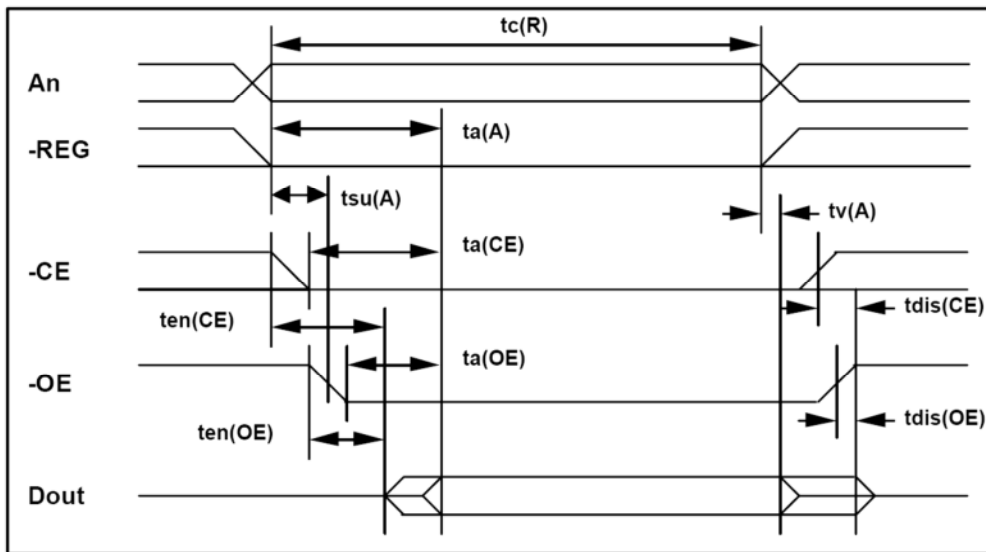


Figure 4-1 Attribute Memory Read Timing

Table 4-2 Attribute Memory Read Timing

Speed Version	Symbol	IEEE Symbol	300 ns.	
Item			Min ns.	Max ns.
	Read Cycle Time	tc(R)	300	
	Address Access Time	ta(a)		300
	Card Enable Access Time	ta(CE)		300
	Output Enable Access	ta(OE)		150
	Output Disable Time from CE	tdis(CE)		100
	Output Disable Time from OE	tdis(OE)		100
	Address Setup Time	tsu(A)	30	
	Output Enable Time from CE	ten(CE)	5	
	Output Enable Time from OE	ten(OE)	5	
	Data Valid from Address Change	tv(A)	0	

Attribute Memory Write Timing

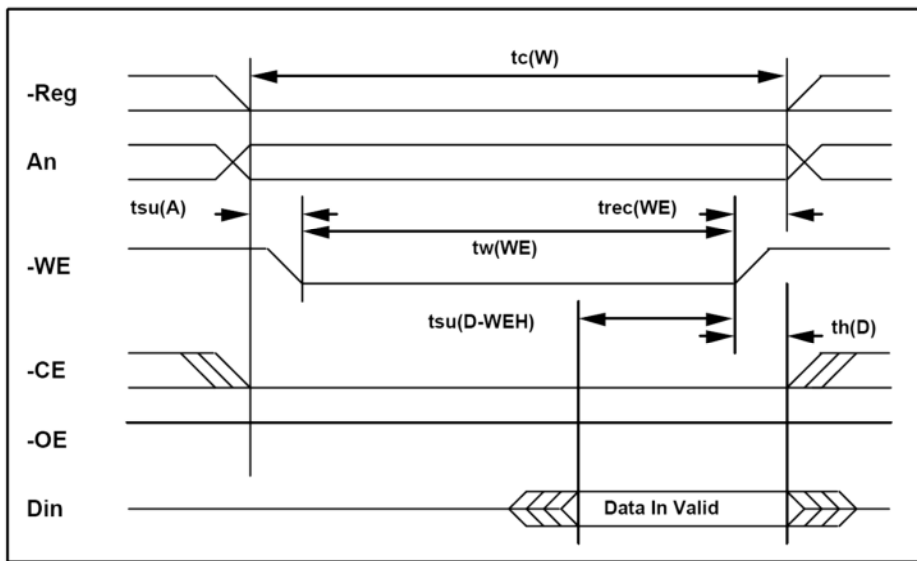


Figure 4-2 Attribute Memory Write Timing

Table 4-3 Attribute Memory Writing Timing

Speed Version	Symbol	IEEE Symbol	250 ns	
			Min ns	Max ns
Write Cycle Time	$t_c(W)$	t_{AVAV}	250	
Write Pulse Width	$t_w(WE)$	t_{WLWH}	150	
Address Setup Time	$t_{su}(A)$	t_{AVWL}	30	
Write Recovery Time	$t_{rec}(WE)$	t_{WMAX}	30	
Data Setup Time for WE	$t_{su}(D-WEH)$	t_{DVWH}	80	
Data Hold Time	$t_h(D)$	t_{WMDX}	30	

Common Memory Read Timing

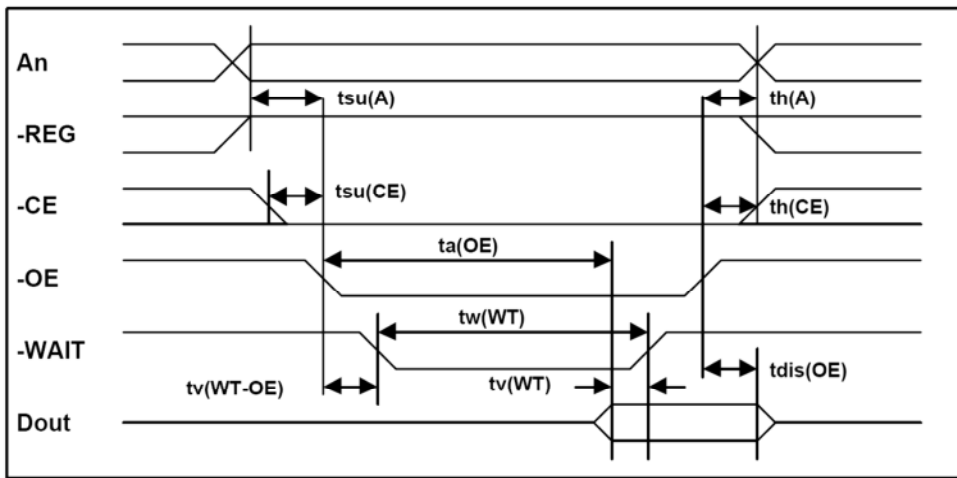


Figure 4-3 Common Memory Read Timing

Table 4-4 Common Memory Read Timing

Cycle Time Mode			250 ns		120 ns		100 ns		80 ns	
Item	Symbol	IEEE Symbol	Min ns.	Max ns.	Min ns.	Max ns.	Min ns.	Max ns.	Min ns.	Max ns.
Output Enable Access Time	$t_a(OE)$	t_{GLQV}		125		60		50		45
Output Disable Time from OE	$t_{dis}(OE)$	t_{GHQZ}		100		60		50		45
Address Setup Time	$t_{su}(A)$	t_{AVGL}	30		15		10		10	
Address Hold Time	$t_h(A)$	t_{GHAX}	20		15		15		10	
CE Setup before OE	$t_{su}(CE)$	t_{ELGL}	0		0		0		0	

CE Hold following OE	th(CE)	tGHEH	20		15		15		10	
Wait Delay Falling from OE	tv(WT-OE)	tGLWTV		35		35		35		na ¹
Data Setup for Wait Release	tv(WT)	tQVWTH		0		0		0		na ¹
Wait Width Time ²	tw(WT)	tWTLWTH		350(3000 for CF+)		350(3000 for CF+)		350(3000 for CF+)		na ¹

NOTES:

- WAIT is not supported in this mode.
- The maximum load on -WAIT is 1 LSTTL with 50pF (40pF below 120nsec Cycle Time) total load. All times are in nanoseconds. Dout signifies data provided by the CompactFlash Storage Card or CF+ Card to the system. The -WAIT signal may be ignored if the -OE cycle to cycle time is greater than the Wait Width time. The Max Wait Width time can be determined from the Card Information Structure. The Wait Width time meets the PCMCIA specification of 12us but is intentionally less in this specification.

Common Memory Write Timing

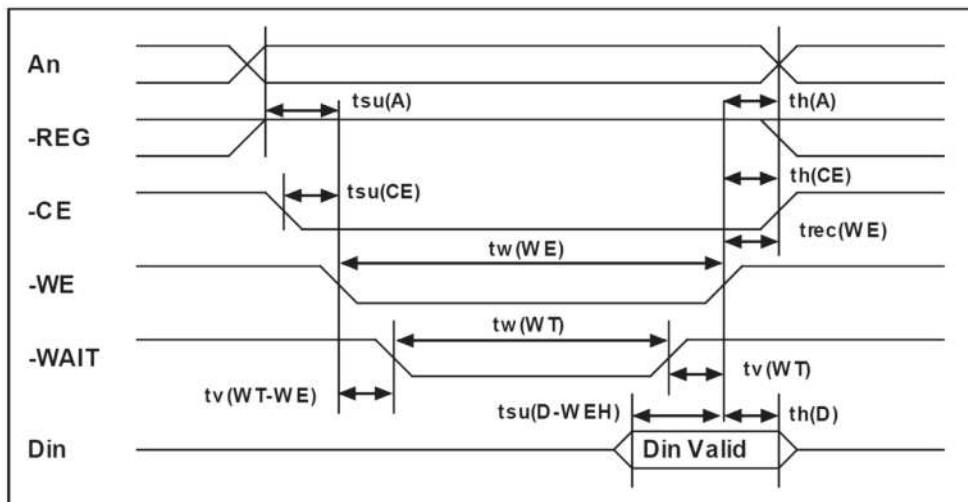


Figure 4-4 Common Memory Write Timing

Table 4-5 Common Memory Write Timing

Cycle Time Mode			250 ns		120 ns		100 ns		80 ns	
Item	Symbol	IEEE Symbol	Min ns.	Max ns.	Min ns.	Max ns.	Min ns.	Max ns.	Min ns.	Max ns.

Data Setup before WE	tsu(D-WEH)	tDVWH	80		50		40		30	
Data Hold following WE	th(D)	tWMDX	30		15		10		10	
WE Pulse Width	tw(WE)	tWLWH	150		70		60		55	
Address Setup Time	tsu(A)	tAVWL	30		15		10		10	
CE Setup before WE	tsu(CE)	tELWL	0		0		0		0	

Cycle Time Mode			250 ns		120 ns		100 ns		80 ns	
Item	Symbol	IEEE Symbol	Min ns.	Max ns.	Min ns.	Max ns.	Min ns.	Max ns.	Min ns.	Max ns.
Write Recovery Time	trec(WE)	tWMAX	30		15		15		15	
Address Hold Time	th(A)	tGHAX	20		15		15		15	
CE Hold following WE	th(CE)	tGHEH	20		15		15		10	
Wait Delay Falling from WE	tv(WT-WE)	tWLWTV		35		35				na ¹
WE High from Wait Release	tv(WT)	tWTHWH	0		0		0		na ¹	
Wait Width Time ²	tw(WT)	tWTLWTH		350(3000 for CF+)		350(3000 for CF+)		350(3000 for CF+)		na ¹

NOTES:

1. –WAIT is not supported in this mode.
2. The maximum load on –WAIT is 1 LSTTL with 50 pF (40pF below 120nsec Cycle Time) total load. All times are in nanoseconds. Din signifies data provided by the system to the CompactFlash Storage Card. The –WAIT signal may be ignored if the –WE cycle to cycle time is greater than the Wait Width time. The Max Wait Width time can be determined from the Card Information Structure. The Wait Width time meets the PCMCIA specification of 12us but is intentionally less in this specification.

I/O Read Timing

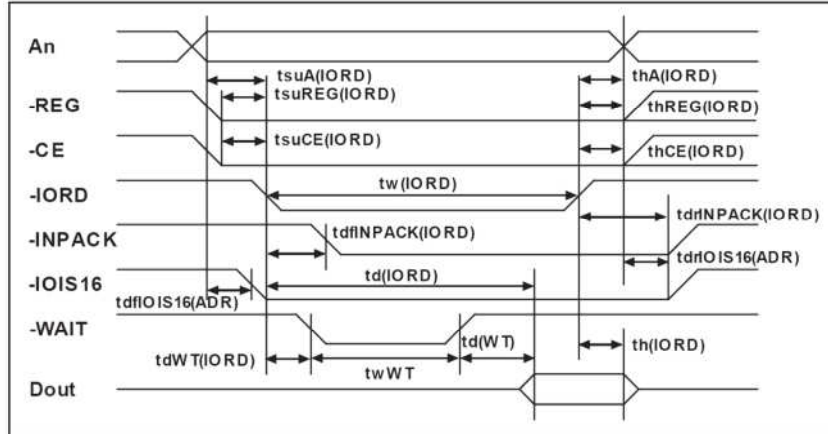


Figure 4-5 I/O Read Timing

Table 4-6 I/O Read Timing

Cycle Time Mode			250 ns		120 ns		100 ns		80 ns	
Item	Symbol	IEEE Symbol	Min (ns.)	Max (ns.)	Min (ns.)	Max (ns.)	Min (ns.)	Max (ns.)	Min (ns.)	Max (ns.)
Data Delay after IORD	td(IORD)	tIGLQV		100		50		50		45
Data Hold following IORD	th(IORD)	tIGHQX	0		5		5		5	
IORD Width Time	tw(IORD)	tIGLIGH	165		70		65		55	
Address Setup before IORD	tsuA(IORD)	tAVIGL	70		25		25		15	
Address Hold following IORD	thA(IORD)	tIGHAX	20		10		10		10	
CE Setup before IORD	tsuCE(IORD)	tELIGL	5		5		5		5	
CE Hold following IORD	thCE(IORD)	tIGHEH	20		10		10		10	
REG Setup before IORD	tsuREG(IORD)	tRGLIGL	5		5		5		5	
REG Hold following IORD	thREG(IORD)	tIGHRGH	0		0		0		0	
INPACK Delay Falling from IORD ³	tdfINPACK(IORD)	tIGLIAL	0	45	0	na ¹	0	na ¹	0	na ¹
INPACK Delay Rising from IORD ³	tdrINPACK(IORD)	tIGHIAH		45		na ¹		na ¹		na ¹

IOIS16 Delay Falling from Address ³	tdfIOIS16 (ADR)	tAVISL		35		na ¹		na ¹		na ¹
IOIS16 Delay Rising from Address ³	tdrIOIS16 (ADR)	tAVISH		35		na ¹		na ¹		na ¹
Wait Delay Falling from IORD ³	tdW T(IORD)	tIGLW TL		35		35		35		na ²
Data Delay from Wait Rising ³	td(W T)	tW THQV		0		0		0		na ²
Wait Width Time ³	tw(W T)	tW TLW TH		350 (3000 for CF+)		350 (3000 for CF+)		350 (3000 for CF+)		na ²

NOTES:

1. -IOIS16 and -INPACK are not supported in this mode.
2. -WAIT is not supported in this mode.
3. Maximum load on -WAIT, -INPACK and -IOIS16 is 1 LSTTL with 50 pF (40pF below 120nsec Cycle Time) total load. All times are in nanoseconds. Minimum time from -WAIT high to -IORD high is 0 nsec, but minimum -IORD width shall still be met. Dout signifies data provided by the CompactFlash Storage Card or CF+ Card to the system. Wait Width time meets PCMCIA PC Card specification of 12µs but is intentionally less in this spec.

I/O Write Timing

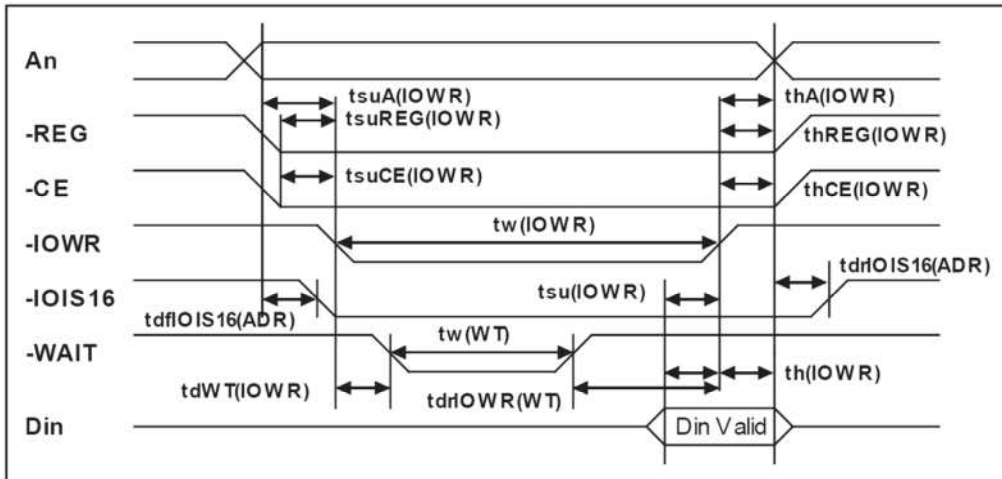


Figure 4-6 I/O Write Timing

Table 4-7 I/O Write Timing

Cycle Time Mode			255 ns		120 ns		100 ns		80 ns	
Item	Symbol	IEEE Symbol	Min (ns.)	Max (ns.)	Min (ns.)	Max (ns.)	Min (ns.)	Max (ns.)	Min (ns.)	Max (ns.)
Data Setup before IOWR	$t_{su(IOWR)}$	tDVIWH	60		20		20		15	
Data Hold following IOWR	$t_{th(IOWR)}$	tIWHDX	30		10		5		5	
IOWR Width Time	$t_w(IOWR)$	tIWLWH	165		70		65		55	
Address Setup before IOWR	$t_{suA(IOWR)}$	tAVIWL	70		25		25		15	
Address Hold following IOWR	$t_{thA(IOWR)}$	tIWHAX	20		20		10		10	
CE Setup before IOWR	$t_{suCE(IOWR)}$	tELIWL	5		5		5		5	
CE Hold following IOWR	$t_{thCE(IOWR)}$	tIWHHEH	20		20		10		10	
REG Setup before IOWR	$t_{suREG(IOWR)}$	tRGLIWL	5		5		5		5	
Cycle Time Mode			255 ns		120 ns		100 ns		80 ns	
Item	Symbol	IEEE Symbol	Min (ns.)	Max (ns.)	Min (ns.)	Max (ns.)	Min (ns.)	Max (ns.)	Min (ns.)	Max (ns.)
REG Hold	$t_{thREG(IOWR)}$	tIWHRGH	0		0		0		0	

following IOWR										
IOIS16 Delay Falling from Address ³	tdfIOIS16 (ADR)	tAVISL		35		na ¹		na ¹		na ¹
IOIS16 Delay Rising from Address ³	tdrIOIS16 (ADR)	tAVISH		35		na ¹		na ¹		na ¹
Wait Delay Falling from IOW R ³	tdW T (IOWR)	tIW LW TL		35		35		35		na ²
IOW R high from Wait High ³	tdrIOW R (W T)	tW TJIWH	0		0		0		na ²	
Wait Width Time ³	Tw (W T)	tW TLW TH		350 (3000 for CF+)		350 (3000 for CF+)		350 (3000 for CF+)		na ²

NOTES:

1. -IOIS16 and -INPACK are not supported in this mode.
2. -WAIT is not supported in this mode.
3. The maximum load on -WAIT, -INPACK, and -IOIS16 is 1 LSTTL with 50 pF (40pF below 120nsec Cycle Time) total load. All times are in nanoseconds. Minimum time from -WAIT high to -IOWR high is 0nsec, but minimum -IOWR width shall still be met. Din signifies data provided by the system to the CompactFlash Storage Card or CF+ Card. The Wait Width time meets the PCMCIA PC Card specification of 12 μs but is intentionally less in this specification.

4.5.2. IDE Interface Timing (PIO Mode)

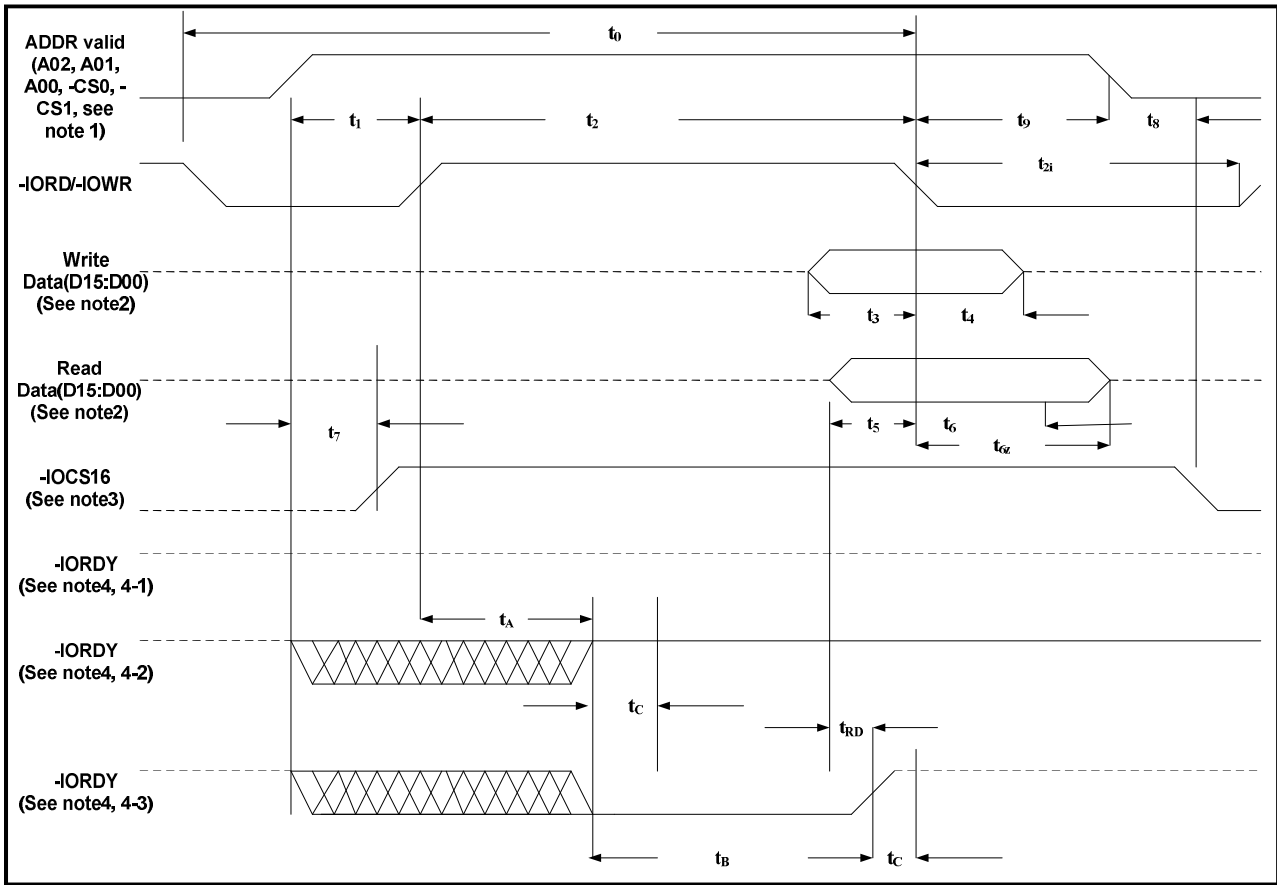


Figure 4-7 IDE Interface Timing (PIO Mode)

NOTES:

1. Device address consists of -CS0, -CS1, and A[02:00]
2. Data consists of D[15::00] (16-bit) or D[07::00] (8 bit)
3. -IOCS16 is shown for PIO modes 0, 1 and 2. For other modes, this signal is ignored.
4. The negation of IORDY by the device is used to extend the PIO cycle. The determination of whether the cycle is to be extended is made by the host after t_A from the assertion of -IORD or -IOWR. The assertion and negation of IORDY is described in the following three cases:
 - Device never negates IORDY: No wait is generated.
 - Device starts to drive IORDY low before t_A , but causes IORDY to be asserted before t_A : No wait generated.
 - Device drives IORDY low before t_A : wait generated. The cycle completes after IORDY is reasserted. For cycles where a wait is generated and -IORD is asserted, the device shall place read data on D15-D00 for t_{RD} before causing IORDY to be asserted.

Table 4-8 IDE Interface Timing

Name	Item	Mode0	Mode1	Mode2	Mode3	Mode4	Mode5	Mode6	Note
t0	Cycle time (min)	600	383	240	180	120	100	80	1
t1	Address Valid to -IORD/-IOWR setup (min)	70	50	30	30	25	15	10	
t2	-IORD/-IOWR (min)	165	125	100	80	70	65	55	1
t2	-IORD/-IOWR (min) Register (8 bit)	290	290	290	80	70	65	55	1
t2i	-IORD/-IOWR recovery time (min)	-	-	-	70	25	25	20	1
t3	-IOWR data setup (min)	60	45	30	30	20	20	15	
t4	-IOWR data hold (min)	30	20	15	10	10	5	5	
t5	-IORD data setup (min)	50	35	20	20	20	15	10	
t6	-IORD data hold (min)	5	5	5	5	5	5	5	
T6Z	-IORD data tristate (max)	30	30	30	30	30	20	20	2
t7	Address valid to -IOCS16 assertion (max)	90	50	40	n/a	n/a	n/a	n/a	4
t8	Address valid to -IOCS16 released (max)	60	45	30	n/a	n/a	n/a	n/a	4
t9	-IORD/-IOWR to address valid hold	20	15	10	10	10	10	10	
tRD	Read Data Valid to IORDY active (min), if IORDY initially low after tA	0	0	0	0	0	0	0	
tA	IORDY Setup time	35	35	35	35	35	na5	na5	3
tB	IORDY Pulse Width (max)	1250	1250	1250	1250	1250	na5	na5	
tC	IORDY assertion to release (max)	5	5	5	5	5	na5	na5	

NOTES:

All timings are in nanoseconds. The maximum load on -IOCS16 is 1 LSTTL with a 50 pF (40pF below 120nsec Cycle Time) total load. All times are in nanoseconds. Minimum time from -IORDY high to -IORD high is 0nsec, but minimum -IORD width shall still be met.

1. t0 is the minimum total cycle time, t2 is the minimum command active time, and t2i is the minimum command recovery time or command inactive time. The actual cycle time equals the sum of the actual command active time and the actual command inactive time. The three timing requirements of t0, t2, and t2i shall be met. The minimum total cycle time requirement is greater than the sum of t2 and t2i. This means a host implementation can lengthen either or both t2 or t2i to ensure that t0 is equal to or greater than the value reported in the device's identify device data. A CompactFlash Storage Card implementation shall support any legal host implementation.

2. This parameter specifies the time from the negation edge of -IORD to the time that the data bus is no longer driven by the CompactFlash Storage Card (tri-state).
3. The delay from the activation of -IORD or -IOWR until the state of IORDY is first sampled. If IORDY is inactive then the host shall wait until IORDY is active before the PIO cycle can be completed. If the CompactFlash Storage Card is not driving IORDY negated at t_A after the activation of -IORD or -IOWR, then t_5 shall be met and t_{RD} is not applicable. If the CompactFlash Storage Card is driving IORDY negated at the time t_A after the activation of -IORD or -IOWR, then t_{RD} shall be met and t_5 is not applicable.
4. t_7 and t_8 apply only to modes 0, 1 and 2. For other modes, this signal is not valid.
5. IORDY is not supported in this mode.

4.5.3. Multi Word DMA

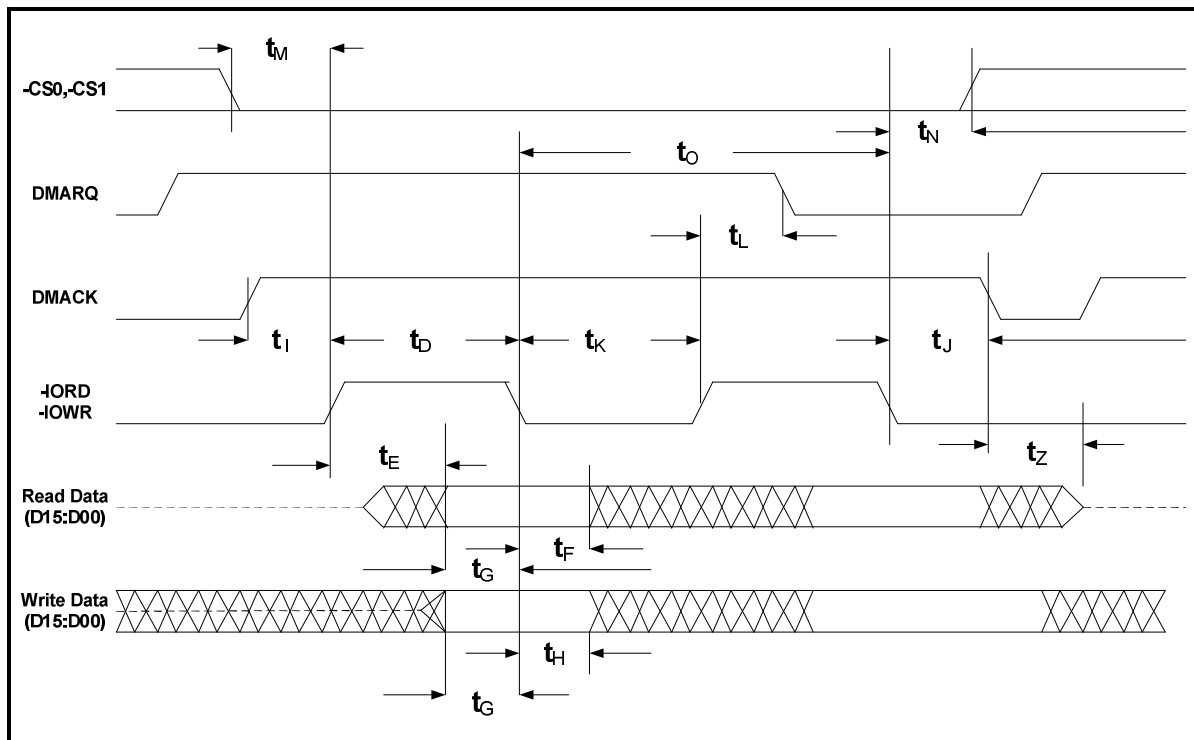


Figure 4-8 Multi Word DMA

NOTES:

All waveforms in this diagram are shown with the asserted state high. Negative true signals appear inverted on the bus relative to the diagram.

1. If the Card cannot sustain continuous, minimum cycle time DMA transfers, it may negate DMARQ within the time specified from the start of a DMA transfer cycle to suspend the DMA transfers in progress and reassert the signal at a later time to continue the DMA operation.
2. This signal may be negated by the host to suspend the DMA transfer in progress.

Table 4-9 MDMA Mode Timing Table

Item		Mode 0	Mode 1	Mode 2	Mode 3	Mode 4	Note
	Symbol	(ns)	(ns)	(ns)	(ns)	(ns)	
t_0	Cycle time (min)	480	150	120	100	80	1
t_D	-IORD / -IOWR asserted width (min)	215	80	70	65	55	1
t_E	-IORD data access (max)	150	60	50	50	45	
t_F	-IORD data hold (min)	5	5	5	5	5	
t_G	-IORD / -IOWR data setup (min)	100	30	20	15	10	
t_H	-IOWR data hold (min)	20	15	10	5	5	
t_I	DMACK to -IORD/-IOWR setup (min)	0	0	0	0	0	
t_J	-IORD / -IOWR to -DMACK hold (min)	20	5	5	5	5	
t_{KR}	-IORD negated width (min)	50	50	25	25	20	1
t_{KW}	-IOWR negated width (min)	215	50	25	25	20	1
t_{LR}	-IOWR to DMARQ delay (max)	120	40	35	35	35	
t_{LW}	-IOWR to DMARQ delay (max)	40	40	35	35	35	
t_M	CS(1:0) valid to -IORD/-IOWR	50	30	25	10	5	
t_N	CS(1:0) hold	15	10	10	10	10	
t_Z	-DMACK	20	25	25	25	25	

NOTE:

- t_0 is the minimum total cycle time and t_D is the minimum command active time, while t_{KR} and t_{KW} are the minimum command recovery time or command inactive time for input and output cycles respectively. The actual cycle time equals the sum of the actual command active time and the actual command inactive time. The three timing requirements of t_0 , t_D , t_{KR} and t_{KW} shall be met. The minimum total cycle time requirement is greater than the sum of t_D , t_{KR} and t_{KW} for input and output cycles respectively. This means a host implementation can lengthen either or both of t_D and either of t_{KR} and t_{KW} as needed to ensure that t_D is equal to or greater than the value reported in the device's identify device data. A CompactFlash Storage Card implementation shall support any legal host implementation.

4.5.4. Ultra DMA

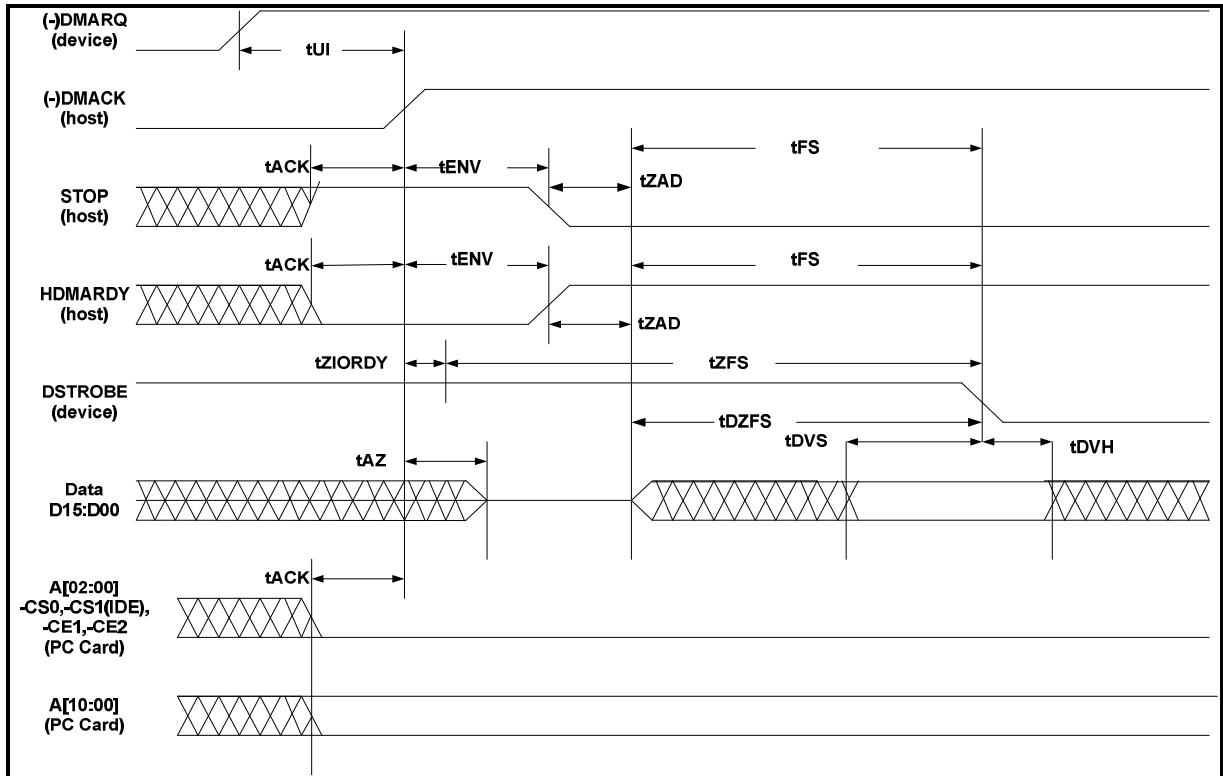


Figure 4-9 Initialize an Ultra DMA Data in Burst Timing

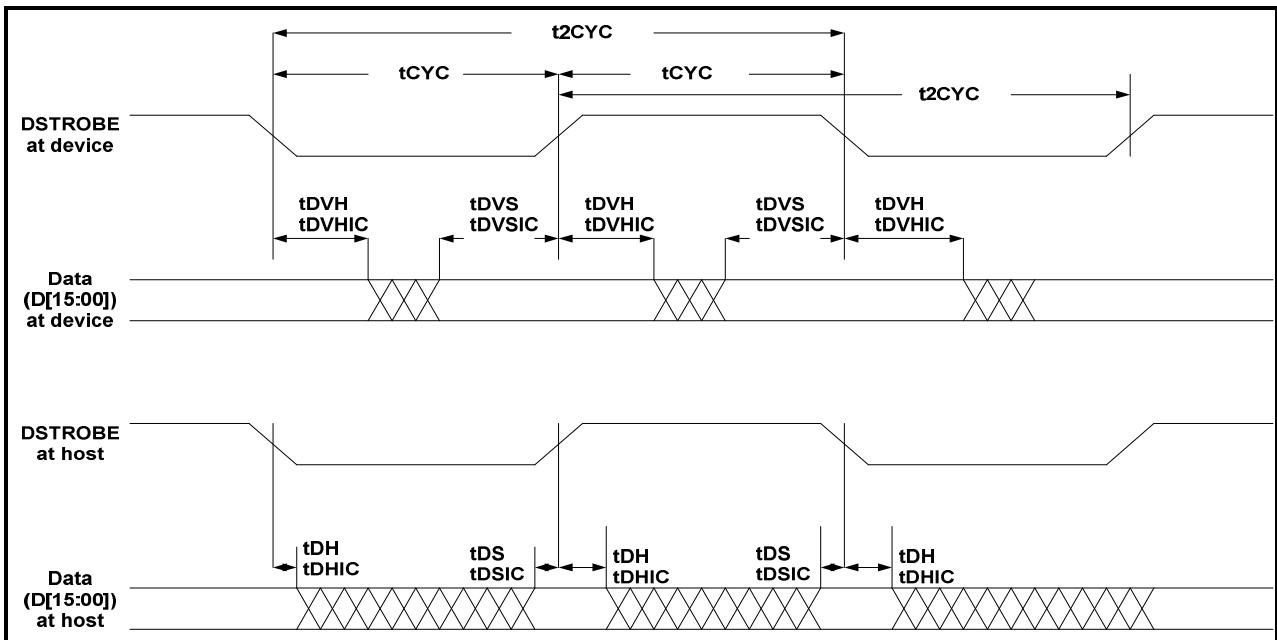


Figure 4-10 Sustained Ultra DMA Data-in Burst Timing

Table 4-10 Ultra DMA Mode Timing

Name	UDMA																Measure
	Mode 0		Mode 1		Mode 2		Mode 3		Mode 4		Mode 5		Mode 6		Mode 7		Location
	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	(See Note 2)
t2CYCTYP	240		160		120		90		60		40		30		24		Sender
tCYC	112		73		54		39		25		16.8		13		10		Note 3
t2CYC	230		153		115		86		57		38		29		23		Sender
tDS	15		10		7		7		5		4		2.6		2.5		Recipient
tDH	5		5		5		5		5		4.6		3.5		2.9		Recipient
tDVS	70		48		31		20		6.7		4.8		4		2.9		Sender
tDVH	6.2		6.2		6.2		6.2		6.2		4.8		4		3.2		Sender
tCS	15		10		7		7		5		5		5		5		Device
tCH	5		5		5		5		5		5		5		5		Device
tCVS	70		48		31		20		6.7		10		10		10		Host
tCVH	6.2		6.2		6.2		6.2		6.2		10		10		10		Host
tZFS	0		0		0		0		0		35		25		15		Device
tDZFS	70		48		31		20		6.7		25		17.5		10.5		Sender
tFS		230		200		170		130		120		90		80		70	Device
tLI	0	150	0	150	0	150	0	100	0	100	0	75	0	60	0	50	Note 4
tMLI	20		20		20		20		20		20		20		20		Host
tUI	0		0		0		0		0		0		0		0		Host
tAZ		10		10		10		10		10		10		10		10	Note 5
tZAH	20		20		20		20		20		20		20		20		Host
tZAD	0		0		0		0		0		0		0		0		Device
tENV	20	70	20	70	20	70	20	55	20	55	20	50	20	50	20	50	Host
tRFS		75		70		60		60		60		50		50		50	Sender
tRP	160		125		100		100		100		85		85		85		Recipient
tIORDYZ		20		20		20		20		20		20		20		20	Device
tZI ORDY	0		0		0		0		0		0		0		0		Device
tACK	20		20		20		20		20		20		20		20		Host
tSS	50		50		50		50		50		50		50		50		Sender

Table 4-11 Ultra DMA Data Burst Timing Descriptions

Name	Comment	Notes
t2CYCTYP	Typical sustained average two cycle time	
tCYC	Cycle time allowing for asymmetry and clock variations (from STROBE edge to STROBE edge)	
t2CYC	Two cycle time allowing for clock variations (from rising edge to next rising edge or from falling edge to next falling edge of STROBE)	
tDS	Data setup time at recipient (from data valid until STROBE edge)	2, 5
tDH	Data hold time at recipient (from STROBE edge until data may become invalid)	2, 5
tDVS	Data valid setup time at sender (from data valid until STROBE edge)	3
tDVH	Data valid hold time at sender (from STROBE edge until data may become invalid)	3
tCS	CRC word setup time at device	2
tCH	CRC word hold time device	2
tCVS	CRC word valid setup time at host (from CRC valid until -DMACK negation)	3
tCVH	CRC word valid hold time at sender (from -DMACK negation until CRC may become invalid)	3
tZFS	Time from STROBE output released-to-driving until the first transition of critical timing.	
tDZFS	Time from data output released-to-driving until the first transition of critical timing.	
tFS	First STROBE time (for device to first negate DSTROBE from STOP during a data in burst)	
tLI	Limited interlock time	1
tMLI	Interlock time with minimum	1
tUI	Unlimited interlock time	1
tAZ	Maximum time allowed for output drivers to release (from asserted or negated)	
tZAH	Minimum delay time required for output	
tZAD	drivers to assert or negate (from released)	
tENV	Envelope time (from -DMACK to STOP and -HDMARDY during data in burst initiation and from DMACK	
	to STOP during data outburst initiation)	
tRFS	Ready-to-final-STROBE time (no STROBE edges shall be sent this long after negation of -DMARDY)	
tRP	Ready-to-pause time (that recipient shall wait to pause after negating -DMARDY)	

Name	Comment	Notes
tIORDYZ	Maximum time before releasing IORDY	6
tZI ORDY	Minimum time before driving IORDY	4, 6
tACK	Setup and hold times for -DMACK (before assertion or negation)	
tSS	Time from STROBE edge to negation of DMARQ or assertion of STOP (when sender terminates a burst)	

NOTES:

1. The parameters tUI, tMLI, and tLI indicate sender-to-recipient or recipient-to-sender interlocks, i.e., one agent (either sender or recipient) is waiting for the other agent to respond with a signal before proceeding. tUI is an unlimited interlock that has no maximum time value. tMLI is a limited time-out that has a defined minimum. tLI is a limited time-out that has a defined maximum.
2. 80-conductor cabling shall be required in order to meet setup (tDS, tCS) and hold (tDH, tCH) times in modes greater than 2.
3. Timing for tDVS, tDVH, tCVS and tCVH shall be met for lumped capacitive loads of 15 and 40 pF at the connector where the Data and STROBE signals have the same capacitive load value. Due to reflections on the cable, these timing measurements are not valid in a normally functioning system.
4. For all timing modes the parameter tZIORDY may be greater than tENV due to the fact that the host has a pull-up on IORDY- giving it a known state when released.
5. The parameters tDS and tDH for mode 5 are defined for a recipient at the end of the cable only in a configuration with a single device located at the end of the cable. This could result in the minimum values for tDS and tDH for mode 5 at the middle connector being 3.0 and 3.9 ns respectively.
6. This parameter applies to True IDE mode operation only.

5. INTERFACE



5.1. Pin Assignment and Descriptions

Table 5-1 CompactFlash™ Interface Pin Assignments

PC Card Memory Mode			PC Card I/O Mode			True IDE Mode		
Pin #	Signal Name	Pin Type	Pin #	Signal Name	Pin Type	Pin #	Signal Name	Pin Type
1	GND		1	GND		1	GND	I/O
2	D03	I/O	2	D03	I/O	2	D03	I/O
3	D04	I/O	3	D04	I/O	3	D04	I/O
4	D05	I/O	4	D05	I/O	4	D05	I/O
5	D06	I/O	5	D06	I/O	5	D06	I/O
6	D07	I/O	6	D07	I/O	6	D07	I
7	-CE1	I	7	-CE1	I	7	-CS0	I
8	A10	I	8	A10	I	8	A10	I
9	-OE	I	9	-OE	I	9	-ATA SEL	I
10	A09	I	10	A09	I	10	A09	I
11	A08	I	11	A08	I	11	A08	I
12	A07	I	12	A07	I	12	A07	
13	VCC		13	VCC		13	VCC	I
14	A06	I	14	A06	I	14	A06	I
15	A05	I	15	A05	I	15	A05	I
16	A04	I	16	A04	I	16	A04	I
17	A03	I	17	A03	I	17	A03	I
18	A02	I	18	A02	I	18	A02	I
19	A01	I	19	A01	I	19	A01	I
20	A00	I	20	A00	I	20	A00	I/O
21	D00	I/O	21	D00	I/O	21	D00	I/O
22	D01	I/O	22	D01	I/O	22	D01	I/O
23	D02	I/O	23	D02	I/O	23	D02	O
24	WP	O	24	-IOIS16	O	24	-IOIS16	O
25	-CD2	O	25	-CD2	O	25	-CD2	O
26	-CD1	O	26	-CD1	O	26	-CD1	I/O
27	D11	I/O	27	D11	I/O	27	D11	I/O
28	D12	I/O	28	D12	I/O	28	D12	I/O
29	D13	I/O	29	D13	I/O	29	D13	I/O
30	D14	I/O	30	D14	I/O	30	D14	I/O
31	D15	I/O	31	D15	I/O	31	D15	I

PC Card Memory Mode			PC Card I/O Mode			True IDE Mode		
Pin #	Signal Name	Pin Type	Pin #	Signal Name	Pin Type	Pin #	Signal Name	Pin Type
32	-CE2	I	32	-CE2	I	32	-CS1	O
33	-VS1	O	33	-VS1	O	33	-VS1	I
34	-IORD	I	34	-IORD	I	34	-IORD	I
35	-IOWR	I	35	-IOWR	I	35	-IOWR	I
36	-WE	I	36	-WE	I	36	-WE	I
37	RDY/BSY	O	37	IREQ	O	37	INTRQ	
38	VCC		38	VCC		38	VCC	I
39	-CSEL	I	39	-CSEL	I	39	-CSEL	I
40	-VS2	O	40	-VS2	O	40	-VS2	I
41	RESET	I	41	RESET	I	41	RESET	O
42	-WAIT	O	42	-WAIT	O	42	IORDY	O
43	-INPACK	O	43	-INPACK	O	43	-INPACK	I
44	-REG	I	44	-REG	I	44	-REG	I/O
45	BVD2	I/O	45	-SPKR	I/O	45	-DASP	I/O
46	BVD1	I/O	46	-STSCHG	I/O	46	-PDIAG	I/O
47	D08	I/O	47	D08	I/O	47	D08	I/O
48	D09	I/O	48	D09	I/O	48	D09	I/O
49	D10	I/O	49	D10	I/O	49	D10	
50	GND		50	GND		50	GND	

NOTES:

1. WE should be connected to VCC in True IDE mode.
2. CSEL is the input pin for master/slave selection used in True IDE mode.

Table 5-2 Power Segment Pin Assignment and Descriptions

Signal Name	Dir.	Pin	Description
BVD2 (PC Card Memory Mode)	I/O	45	This output line is always driven to a high state in Memory Mode since a battery is not required for this product
-SPKR (PC CARD I/O Mode)			This output line is always driven to a high state in I/O Mode since this product does not support the audio function
-DASP (True IDE Mode)			In the True IDE Mode, this input/output is the Disk Active/Slave Present signal in the Master/Slave handshake protocol
-CD1,-CD2 (PC Card Memory Mode)	O	26, 25	These card detect pins are connected to the ground on the CompactFlash™ Storage Card. They are used by the host to determine that the CompactFlash™ Storage Card is fully inserted into its socket.
-CD1,-CD2 (PC Card I/O Mode)			The signal is the same for all modes
-CD1,-CD2 (True IDE Mode)			The signal is the same for all modes
D[15:0] (PC Card Memory Mode)	I/O	31, 30, 29, 28, 27, 49, 48, 47, 6, 5, 4, 3, 2, 23, 22, 21	These lines carry the Data, Commands, and Status information between the host and the controller. D00 is the LSB of the Odd Byte of the World
D[15:0] (PC Card I/O Mode)			The signal is the same as the PC Card Memory Mode signal.
D[15:0] (True IDE Mode)			In True IDE Mode, all Task File operations occur in byte mode on the lower order bus D00-D07 while all data transfers are 16 bit using D00-D15.
-IOWR (PC Card Memory Mode)	I	35	This signal is not used in this mode.
-IOWR (PC Card I/O Mode)			The I/O Write strobe pulse is used to clock I/O data on the Card Data bus into the CompactFlash™ Storage Card or CF+ Card controller registers when the CompactFlash™ Storage Card or CF+ Card is configured to use the I/O interface.
-IOWR (True IDE Mode – Except Ultra DMA Protocol Active)			The clocking shall occur on the negative to positive edge of the signal (trailing edge). In True IDE Mode, while Ultra DMA mode protocol is not active, this signal has the same function as in PC Card I/O Mode.
STOP (True IDE Mode – Ultra DMA Protocol Active)			When Ultra DMA mode protocol is supported, this signal must be negated before entering Ultra DMA mode protocol. In True IDE Mode, while Ultra DMA mode protocol is active, the assertion of this signal causes the termination of the Ultra DMA burst.
-IORD (PC Card Memory Mode)	I	34	This signal is not used in this mode.

Signal Name	Dir.	Pin	Description
-IORD (PC Card I/O Mode)			This is an I/O Read strobe generated by the host. This signal gates I/O data onto the bus from the CompactFlash™ Storage Card or CF+ Card when the card is configured to use the I/O interface.
-IORD (True IDE Mode – Except Ultra DMA Protocol Active)			In True IDE Mode, while Ultra DMA mode is not active, this signal has the same function as in PC Card I/O Mode.
-HDMARDY (True IDE Mode – In Ultra DMA Protocol DMA Read)			In True IDE Mode when Ultra DMA mode DMA Read is active, this signal is asserted by the host to indicate that the host is ready to receive Ultra DMA data-in burst. The host may negate –HDMARDY to pause an Ultra DMA transfer.
-HSTROBE (True IDE Mode – In Ultra DMA Protocol DMA Write)			In True IDE Mode when Ultra DMA mode DMA Write is active, this signal is the data out strobe generated by the host. Both the rising and falling edge of HSTROBE cause data to be latched by the device. The host may stop generating HSTROBE edges to pause an Ultra DMA data-out burst.
-WE (PC Card Memory Mode)	I	36	This signal is driven by the host and used for strobing memory write data to the registers of the CompactFlash™ Storage Card when the card is configured in the memory interface mode. It is also used for writing the configuration registers.
-WE (PC Card I/O Mode)			In PC Card I/O Mode, this signal is used for writing the configuration registers.
-WE (True IDE Mode)			In True IDE Mode this input signal is not used and should be connected to VCC by the host.
-OE (PC Card Memory Mode)	I	9	This is an Output Enable strobe generated by the host interface. It is used to read data from the CompactFlash™ Storage Card in Memory Mode and to read the CIS and configuration registers.
-OE (PC Card I/O Mode)			In PC Card I/O Mode this input, this signal is used to read the CIS and configuration registers.
-OE (True IDE Mode)			To enable True IDE Mode this input should be grounded by the host.
RDY/-BSY (PC Card Memory Mode)	O	37	In Memory Mode this signal is set high when the CompactFlash™ Storage Card is ready to accept a new data transfer operation and held low when the card is busy. The Host memory card socket must provide a pull-up resistor. At power up and at Reset, the RDY/-BSY is held low (busy) until the CompactFlash™ Storage Card has completed its power up or reset function. No access of any type should be made to the CompactFlash™ Storage Card during this time. The RDY/-BSY signal is held high (disabled from being busy) whenever the following condition is true: The CompactFlash™ Storage Card has been powered up with +RESET continuously disconnected or asserted.

Signal Name	Dir.	Pin	Description
-IREQ (PC Card I/O Mode)			I/O Operation- After the CompactFlash™ Storage has been configured for I/O operation, this signal is used as – Interrupt Request. This line is strobed low to generate a pulse mode interrupt or held low for a level mode interrupt.
INTRQ (True IDE Mode)			In True IDE Mode signal is an active high Interrupt Request to the host.
A[10:0] (PC Card Memory Mode)	I	8, 10, 11, 12, 14, 15, 16, 17,	These address lines along with the –REG signal are used to select the following: The I/O port address registers within the CompactFlash™ Storage Card, the memory mapped port address registers within the CompactFlash™ Storage Card, a byte in the card’s information structure and its configuration control and status registers.
A[10:0] (PC Card I/O Mode)		18, 19, 20	The signal is the same as the PC Card Memory Mode signal.
A[2:0] (True IDE Mode)			In True IDE Mode only HA[2:0] are used to select the one of eight registers in the Task File, the remaining address lines should be grounded by the host .
-CE1,-CE2 (PC Card Memory Mode) Card Enable	I	7, 32	These input signals are used to select the card and to indicate to the card whether a byte or a word operation is being performed. –CE2 always accesses the odd byte of the word. –CE1 accesses the even byte or the Odd byte of the word depending on the A0 and –CE2. A multi-plexing scheme based on A0, –CE1, –CE2 allows 8 bit hosts to access all data on D0-D7.
-CE1,-CE2 (PC Card I/O Mode) Card Enable			This signal is the same as the PC Card Memory Mode signal.
-CS0,-CS1 (True IDE Mode)			In the True IDE Mode CS0 is the chip select for the task file registers while CS2 is used to select the Alternate Status Register and the Device Control Register.
-CSEL (PC Card Memory Mode)			This signal is not used for this mode.
-CSEL (PC Card I/O Mode)			This signal is not used for this mode.
-CSEL (True IDE Mode)	I	39	This internally pulled up signal is used to configure this device as a Master or a Slave when configured in the True IDE Mode. When this pin is grounded, this device is configured as a Master. When the pin is open, this device is configured as a Slave.
-REG (PC Card Memory Mode) Attribute Memory Select	I	44	This signal is used during Memory Cycles to distinguish between Common Memory and Register (Attribute) Memory accesses. High for Common Memory, Low for Attribute Memory
-REG (PC Card I/O Mode)			The signal shall also be active (low) during I/O Cycles when the I/O address is on the Bus.

Signal Name	Dir.	Pin	Description
-DMACK (True IDE Mode)			This is a DMA Acknowledge signal that is asserted by the host in response to DMARQ to initiate DMA transfers. While DMA operations are not active, the card shall ignore -DMACK signal, including a floating condition. If DMA operation is not supported by a True IDE Mode only host, this signal should be driven high or connected to VCC by the host. A host that does not support DMA mode and implements both PCMCIA and True-IDE modes of operation need not alter the PCMCIA mode connections while in True-IDE mode as long as this does not prevent proper operation all modes.
WP (PC Card Memory Mode) Write Protect			Memory Mode- The CompactFlash™ Storage Card does not have a write protect switch. This signal is held low after the addressed port.
-IOIS 16 (PC Card I/O Mode)	O	24	I/O Operation- When the CompactFlash™ Storage Card is configured for I/O Operation Pin 24 is used for the –I/O Selected is a 16 Bit Port (-IOIS16) function. A Low signal indicates that a 16 bit or odd byte only operation can be performed at the addressed port.
-IOIS 16 (True IDE Mode)			In True IDE Mode this output signal is asserted low when this device is expecting a word data transfer cycle.
-VS1 -VS2 (PC Card Memory Mode)			Voltage Sense Signals. –VS1 is grounded so that the CompactFlash™ Storage Card CIS can be read at 3.3 volts and –VS2 is reserved by PCMCIA for a secondary voltage.
-VS1 -VS2 (PC Card I/O Mode)	O	33 40	This signal is the same for all modes.
-VS1 -VS2 (True IDE Mode)			This signal is the same for all modes.
-INPACK (PC Card Memory Mode)			This signal is not used in this mode.
-INPACK (PC Card I/O Mode) Input Acknowledge	O	43	The Input Acknowledge signal is asserted by the CompactFlash™ Storage Card or CF+ Card when the card is selected and responding to an I/O read cycle at the address that is on the address bus. This signal is used by the host to control the enable of any input data buffers between CompactFlash™ Storage Card or CF+ Card and the CPU.

Signal Name	Dir.	Pin	Description
-DMARQ (True IDE Mode)			<p>This signal is a DMA Request that is used for DMA data transfers between host and device. It shall be asserted by the device when it is ready to transfer data to or from the host. For Multiword DMA transfers, the direction of data transfer is controlled by –IORD and –IOWR. This signal is used in a handshake manner with –DMACK, ie: the device shall wait until the host asserts –DMACK before negating DMARQ, and re-asserting DMARQ if there is more data to transfer.</p> <p>DMARQ shall not be driven when the device is not selected.</p> <p>While a DMA operation is in progress, –CS0 and –CS1 shall be held negated and the width of the transfers shall be 16 bits.</p> <p>If there is no hardware support for DMA mode in the host, this output signal is not used and should not be connected at the host. In this case, the BIOS must report that DMA mode is not supported by the host so that device drivers will not attempt DMA mode.</p> <p>A host that does not support DMA mode and implements both PCMCIA and True-IDE modes of operation need not alter the PCMCIA mode connections while in True-IDE mode as long as this does not prevent proper operation in any mode.</p>
BVD1 (PC Card Memory Mode)			This signal is asserted high as the BVD1 signal since a battery is not used with this product.
-STSCHG (PC Card I/O Mode) Status Changed	I/O	46	This signal is asserted low to alert the host to changes in the RDY/-BSY and Write Protect states, while the I/O interface is configured. Its use is controlled by the Card Config and Status Register.
-PDIAG (True IDE Mode)			In the True IDE Mode, this input / output is the Pass Diagnostic signal in the Master / Slave handshake protocol.
-WAIT (PC Card Memory Mode)			The –WAIT signal is driven low by the CompactFlash™ Storage Card or CF+ Card to signal the host to delay completion of a memory or I/O cycle that is in progress.
-WAIT (PC Card I/O Mode)			This signal is the same as the PC Card Memory Mode signal.
IORDY (True IDE Mode – Except Ultra DMA Mode)	O	42	In True IDE Mode, except in Ultra DMA modes, this output signal may be used as IORDY.
-DDMARDY (True IDE Mode – Ultra DMA Write Mode)			In True IDE Mode, when Ultra DMA mode DMA Write is active, this signal is asserted by the host to indicate that the device is ready to receive Ultra DMA data-in bursts. The device may negate –DDMARDY to pause an Ultra DMA transfer.

Signal Name	Dir.	Pin	Description
-DSTROBE (True IDE Mode – Ultra DMA Read Mode)			In True IDE Mode, when Ultra DMA mode DMA Write is active, this signal is the data out strobe generated by the device. Both the rising and falling edge of DSTROBE cause data to be latched by the host. The device may stop generating DSTROBE edges to pause an Ultra DMA data-out burst.
GND (PC Card Memory Mode)	--	1, 50	Ground.
GND (PC Card I/O Mode)			This signal is the same for all modes.
GND (True IDE Mode)			This signal is the same for all modes.
VCC (PC Card Memory Mode)	--	13, 38	+5V, +3.3V power
VCC (PC Card I/O Mode)			This signal is the same for all modes.
VCC (True IDE Mode)			This signal is the same for all modes.
RESET (PC Card Memory Mode)	I	41	When the pin is high this signal Resets the CompactFlash™ Storage Card. The CompactFlash™ Storage Card is Reset only at power up if this pin is left high or open from power up. The CompactFlash™ Storage Card is also Reset when the Soft Reset bit in the Card Configuration Option Register is set.
RESET (PC Card I/O Mode)			The signal is the same as the PC Card Memory Mode signal.
RESET (True IDE Mode)			In the True IDE Mode this input pin is the active low hardware reset from the host.

Table 5-3 CHS Parameters per Capacity

Capacity	CHS			
	Cylinders	Head	Sector	Total Sector
256MB	493	16	63	496,944
512MB	991	16	63	998,928
1GB	1,966	16	63	1,981,728
2GB	3,900	16	63	3,931,200
4GB	7,785	16	63	7,847,280
8GB	15,538	16	63	15,662,304
16GB	31,045	16	63	31,293,360
32GB	62,041	16	63	62,537,328
64GB	16,383	15	63	125,059,072
128GB	16,383	15	63	250,085,376

6. SUPPORTED COMMANDS



6.1. Identify Drive Information

Table 6-1 List of Drive Information

Word Address	Default Value	Total Bytes	Data Field Type Information
0	848AH	2	General configuration bit-significant information
1	XXXX	2	Default number of cylinders
2	0000H	2	Reserved
3	XXXX	2	Default number of heads
4	0000H	2	Retired
5	0200H	2	Retired
6	XXXX	2	Default number of sectors per track
7-8	XXXXh	4	Number of sectors per card
9	0000H	2	Retired
10-19	XXXX	20	Serial Number in ASCII
20	0002H	2	Retired
21	0002H	2	Retired
22	0004H	2	Obsolete
23-26	XXXX	8	Firmware revision in ASCII
27-46	XXXX	40	Model number in ASCII
47	0001H	2	Maximum number of sector that shall be transferred on Read/Write Multiple commands
48	0000H	2	Reserved
49	0300H	2	Obsolete
50	0000H	2	Reserved
51	0200H	2	PIO data transfer cycle timing mode 2
52	0000H	2	Retired
53	0007H	2	Word 54-58, 64-70 and 88 are valid
54	XXXX	2	Current numbers of cylinders
55	XXXX	2	Current numbers of heads
56	XXXX	2	Current sectors per track
57-58	XXXX	4	Current capacity in sectors (LBAs)(Word 57= LSW, Word 58= MSW)
59	0101H	2	Multiple sector setting is valid
60-61	XXXX	4	Total number of sectors addressable in LBA Mode

Word Address	Default Value	Total Bytes	Data Field Type Information
62	0000H	2	Retired
63	0007H	2	Multiword DMA mode 2 and below are supported
64	0003H	2	Advance PIO transfer modes supported
65	0078H	2	Minimum Multiword DMA transfer cycle time 120nsec
66	0078H	2	Manufacturer's recommended Multiword DMA transfer cycle time 120nsec
67	0078H	2	Minimum PIO transfer cycle time without flow control 120nsec
68	0078H	2	Minimum PIO transfer cycle time with IORDY flow control 120nsec
69-81	0000H	26	Reserved
82	0002H	2	Supports Security Mode feature set
83-87	0000H	10	Reserved
88	0xxxH	2	Ultra DMA mode 7 and below are supported
89-127	0000H	78	Reserved
128	0021H	2	Enhanced security erase supported
129-159	0000H	62	Reserved vendor unique bytes
160-255	0000H	192	Reserved

6.2. CIS Information

Table 6-2 CIS Information

Address	Data	Description of Contents	CIS Function
000H	01H	CISTPL_DEVICE	Tuple code
002H	04H	TPL_LINK	Tuple link
004H	DFH	Device information	Tuple data
006H	4AH	Device information	Tuple data
008H	01H	Device information	Tuple data
00AH	FFH	END MARKER	End of Tuple
00CH	1CH	CISTPL_DEVICE_OC	Tuple code
00EH	04H	TPL_LINK	Tuple link
010H	02H	Conditions information	Tuple data
012H	D9H	Device information	Tuple data
014H	01H	Device information	Tuple data
016H	FFH	END MARKER	End of Tuple
018H	18H	CISTPL_JEDEC_C	Tuple code
01AH	02H	TPL_LINK	Tuple link
01CH	DFH	PCMCIA's manufacturer's JEDEC ID code	Tuple data
01EH	01H	PCMCIA's JEDEC device code	Tuple data
020H	20H	CISTPL_MANFID	Tuple code
022H	04H	TPL_LINK	Tuple link
024H	0AH	Low byte of manufacturer's ID code	Tuple data
026H	00H	High byte of manufacturer's ID code	Tuple data
028H	00H	Low byte of product code	Tuple data
02AH	00H	High byte of product code	Tuple data
02CH	15H	CISTPL_VERS_1	Tuple code
02EH	13H	TPL_LINK	Tuple link
030H	04H	TPLL1_MAJOR	Tuple data
032H	01H	TPLL1_MINOR	Tuple data
034H	50H	'' (Vender Specific Strings)	Tuple data
036H	48H	'' (Vender Specific Strings)	Tuple data
038H	49H	'' (Vender Specific Strings)	Tuple data
03AH	53H	'' (Vender Specific Strings)	Tuple data
03CH	4FH	'' (Vender Specific Strings)	Tuple data

Address	Data	Description of Contents	CIS Function
03EH	4EH	'' (Vender Specific Strings)	Tuple data
040H	00H	Null Terminator	Tuple data
042H	43H	'' (Vender Specific Strings)	Tuple data
044H	46H	'' (Vender Specific Strings)	Tuple data
046H	20H	'' (Vender Specific Strings)	Tuple data
048H	43H	'' (Vender Specific Strings)	Tuple data
04AH	61H	'' (Vender Specific Strings)	Tuple data
04CH	72h	'' (Vender Specific Strings)	Tuple data
04EH	64H	'' (Vender Specific Strings)	Tuple data
050H	00H	Null Terminator	Tuple data
052H	00H	Reserved (Vender Specific Strings)	Tuple data
054H	FFH	END MARKER	End of Tuple
056H	21H	CISTPL_FUNCID	Tuple code
058H	02H	TPL_LINK	Tuple link
05AH	04H	IC Card function code	Tuple data
05CH	01H	System initialization bit mask	Tuple data
05EH	22H	CISTPL_FUNCE	Tuple code
060H	02H	TPL_LINK	Tuple link
062H	01H	Type of extended data	Tuple data
064H	01H	Function information	Tuple data
066H	22H	CISTPL_FUNCE	Tuple code
068H	03H	TPL_LINK	Tuple link
06AH	02H	Type of extended data	Tuple data
06CH	0CH	Function information	Tuple data
06EH	0FH	Function information	Tuple data
070H	1AH	CISTPL_CONFIG	Tuple code
072H	05H	TPL_LINK	Tuple link
074H	01H	Size field	Tuple data
076H	03H	Index number of last entry	Tuple data
078H	00H	Configuration register base address (Low)	Tuple data
07AH	02H	Configuration register base address (High)	Tuple data
07CH	0FH	Configuration register present mask	Tuple data
07EH	1BH	CISTPL_CFTABLE_ENTRY	Tuple code
080H	08H	TPL_LINK	Tuple link
082H	C0H	Configuration Index Byte	Tuple data

Address	Data	Description of Contents	CIS Function
084H	C0H	Interface Descriptor	Tuple data
086H	A1H	Feature Select	Tuple data
088H	01H	Vcc Selection Byte	Tuple data
08AH	55H	Nom V Parameter	Tuple data
08CH	08H	Memory length (256 byte pages)	Tuple data
08EH	00H	Memory length (256 byte pages)	Tuple data
090H	20H	Misc features	Tuple data
092H	1BH	CISTPL_CFTABLE_ENTRY	Tuple code
094H	06H	TPL_LINK	Tuple link
096H	00H	Configuration Index Byte	Tuple data
098H	01H	Feature Select	Tuple data
09AH	21H	Vcc Selection Byte	Tuple data
09CH	B5H	Nom V Parameter	Tuple data
09EH	1EH	Nom V Parameter	Tuple data
0A0H	4DH	Peak I Parameter	Tuple data
0A2H	1BH	CISTPL_CFTABLE_ENTRY	Tuple code
0A4H	0AH	TPL_LINK	Tuple link
0A6H	C1H	Configuration Index Byte	Tuple data
0A8H	41H	Interface Descriptor	Tuple data
0AAH	99H	Feature Select	Tuple data
0ACH	01H	Vcc Selection Byte	Tuple data
0AEH	55H	Nom V Parameter	Tuple data
0B0H	64H	I/O Parameter	Tuple data
0B2H	F0H	IRQ parameter	Tuple data
0B4H	FFH	IRQ request mask	Tuple data
0B6H	FFH	IRQ request mask	Tuple data
0B8H	20H	Misc features	Tuple data
0BAH	1BH	CISTPL_CFTABLE_ENTRY	Tuple code
0BCH	06H	TPL_LINK	Tuple link
0BEH	01H	Configuration Index Byte	Tuple data
0C0H	01H	Feature Select	Tuple data
0C2H	21H	Vcc Selection Byte	Tuple data
0C4H	B5H	Nom V Parameter	Tuple data
0C6H	1EH	Nom V Parameter	Tuple data
0C8H	4DH	Peak I parameter	Tuple data

Address	Data	Description of Contents	CIS Function
0CAH	1BH	CISTPL_CFTABLE_ENTRY	Tuple code
0CCH	0FH	TPL_LINK	Tuple link
0CEH	C2H	Configuration Index Byte	Tuple data
0D0H	41H	Interface Descriptor	Tuple data
0D2H	99H	Feature Select	Tuple data
0D4H	01H	Vcc Selection Byte	Tuple data
0D6H	55H	Nom V Parameter	Tuple data
0D8H	EAH	I/O parameter	Tuple data
0DAH	61H	I/O range length and size	Tuple data
0DCH	F0H	Base address	Tuple data
0DEH	01H	Base address	Tuple data
0E0H	07H	Address length	Tuple data
0E2H	F6H	Base address	Tuple data
0E4H	03H	Base address	Tuple data
0E6H	01H	Address length	Tuple data
0E8H	EEH	IRQ parameter	Tuple data
0EAH	20H	Misc features	Tuple data
0ECH	1BH	CISTPL_CFTABLE_ENTRY	Tuple code
0EEH	06H	TPL_LINK	Tuple link
0F0H	02H	Configuration Index Byte	Tuple data
0F2H	01H	Feature Select	Tuple data
0F4H	21H	Vcc Selection Byte	Tuple data
0F6H	B5H	Nom V Parameter	Tuple data
0F8H	1EH	Nom V Parameter	Tuple data
0FAH	4DH	Peak I Parameter	Tuple data
0FCH	1BH	CISTPL_CFTABLE_ENTRY	Tuple code
0FEH	0FH	TPL_LINK	Tuple link
100H	C3H	Configuration Index Byte	Tuple data
102H	41H	Interface Descriptor	Tuple data
104H	99H	Feature Select	Tuple data
106H	01H	Vcc Selection Byte	Tuple data
108H	55H	Nom V Parameter	Tuple data
10AH	EAH	I/O parameter	Tuple data
10CH	61H	I/O range length and size	Tuple data
10EH	70H	Base address	Tuple data

Address	Data	Description of Contents	CIS Function
110H	01H	Base address	Tuple data
112H	07H	Address length	Tuple data
114H	76H	Base address	Tuple code
116H	03H	Base address	Tuple link
118H	01H	Address length	Tuple data
11AH	EEH	IRQ parameter	Tuple data
11CH	20H	Misc features	Tuple data
11EH	1BH	CISTPL_CFTABLE_ENTRY	Tuple code
120H	06H	TPL_LINK	Tuple link
122H	03H	Configuration Index Byte	Tuple data
124H	01H	Feature Select	Tuple data
126H	21H	Vcc Selection Byte	Tuple data
128H	B5H	Nom V Parameter	Tuple data
12AH	1EH	Nom V Parameter	Tuple data
12CH	4DH	Peak I Parameter	Tuple data
12EH	14H	CISTPL_NO_LINK	Tuple code
130H	00H	TPL_LINK	Tuple link
132H	FFH	CISTPL_END	End of Tuple
134H	FFH	CISTPL_END	End of Tuple
136H	FFH	CISTPL_END	End of Tuple
138H	FFH	CISTPL_END	End of Tuple
13AH	FFH	CISTPL_END	End of Tuple

7. ACRONYMS



Acronym	Definition
CC	Conformal Coating
ECC	Error Correcting Code
LBA	Logical Block Addressing
MLC	Multi-Level Cell
MTBF	Mean Time Between Failures
PLP	Power Loss Protection
pSLC	Pseudo SLC
QE	Quick Erase
SLC	Single-Level Cell
SMART	Self-Monitoring, Analysis and Reporting Technology
WP	Write Protection

8. PART NUMBER DECODER



CFC-ACX¹X²X³X⁴X⁵X⁶X⁷X⁸

Item	Series	Capacity	NAND Flash / Temperature Grade	Data Transfer Mode / Disk Mode	Option
		X¹ X² X³ X⁴	X⁵	X⁶	X⁷ X⁸
CFC	AC	256M (256MB) 512M (512MB) 001G (1GB) 002G (2GB) 004G (4GB) 008G (8GB) 016G (16GB) 032G (32GB) 064G (64GB) 128G (128GB)	C SLC / Standard (0°C ~ +70°C) I SLC / Industrial (-40°C ~ +85°C) K MLC / Standard (0°C ~ +70°C) M MLC / Industrial (-40°C ~ +85°C) P pSLC / Standard (0°C ~ +70°C) F pSLC / Industrial (-40°C ~ +85°C)	P : PIO / Fixed Disk Q : PIO / Removable Disk Z : PIO / Auto Detect M : MWDMA / Fixed Disk N : MWDMA / Removable Disk W : MWDMA / Auto Detect U : UDMA / Fixed Disk V : UDMA / Removable Disk Y : UDMA / Auto Detect	See below

X⁷ X⁸ (Reserved for specific requirement)

Blank: Standard

01 : Write Protection (WP)

02 : Quick Erase (QE)

06 : Conformal Coating (CC)

07 : CC + WP

08 : CC + QE